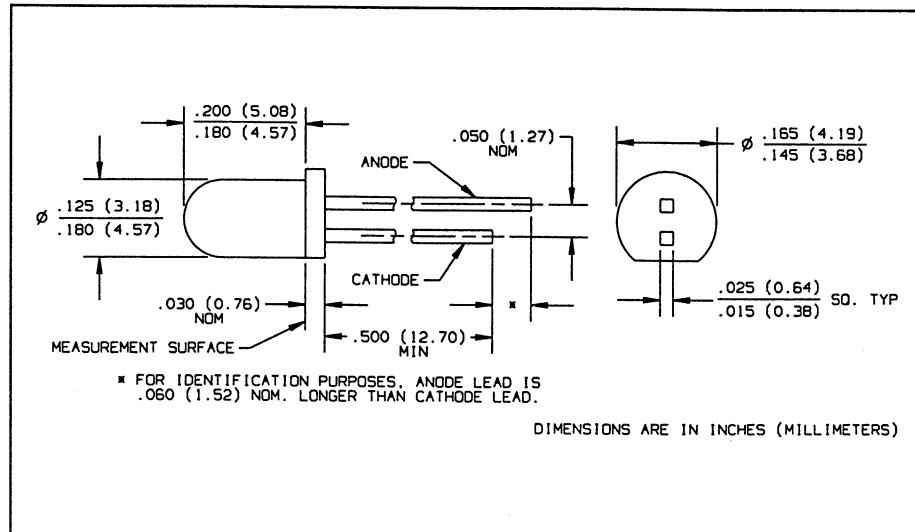
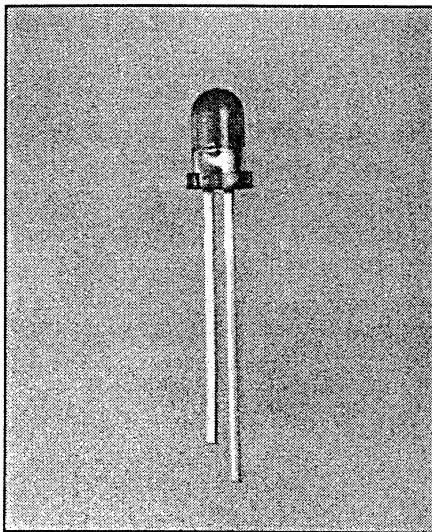


# GaAs Plastic Infrared Emitting Diodes Types OP165A, OP165B, OP165C, OP165D



## Features

- Narrow irradiance pattern
- Mechanically and spectrally matched to the OP505 and OP535 series devices
- Variety of power ranges
- Small package size for space limited applications
- T-1 package style

## Description

The OP165 series devices are 935 nm gallium arsenide infrared emitting diodes molded in IR transmissive amber tinted plastic packages. The narrow irradiance pattern provides high on-axis intensity for excellent coupling efficiency.

## Replaces

K6500 series  
OP163 Series

## Absolute Maximum Ratings ( $T_A = 25^\circ C$ unless otherwise noted)

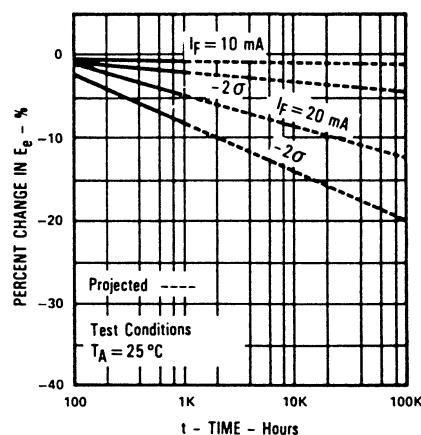
Reverse Voltage .....	2.0 V
Continuous Forward Current .....	50 mA
Peak Forward Current (1 $\mu s$ pulse width, 300 pps) .....	3.0 A
Storage and Operating Temperature Range .....	-40° C to +100° C
Lead Soldering Temperature [1/16 inch (1.6mm) from case for 5 sec. with soldering iron] .....	260° C <sup>(1)</sup>
Power Dissipation .....	100 mW <sup>(2)</sup>

### Notes:

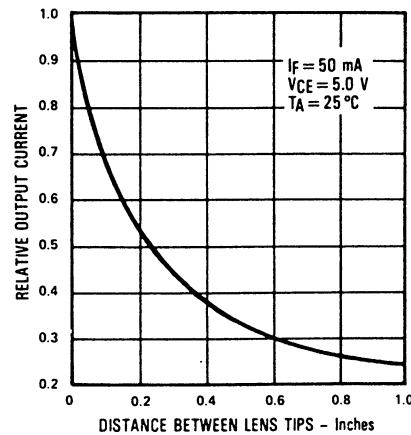
- (1) RMA flux is recommended. Duration can be extended to 10 sec. max. when flow soldering. A max. of 20 grams force may be applied to the leads when soldering.
- (2) Derate linearly 1.33 mW/ $^\circ C$  above 25° C.
- (3)  $E_e(APT)$  is a measurement of the average apertured radiant incidence upon a sensing area 0.081" (2.06 mm) in diameter, perpendicular to and centered on the mechanical axis of the lens, and 0.590" (14.99 mm) from the measurement surface.  $E_e(APT)$  is not necessarily uniform within the measured area.

## Typical Performance Curves

Percent Changes in Radiant Intensity  
vs Time



Coupling Characteristics  
OP165 and OP505



# Types OP165A, OP165B, OP165C, OP165D

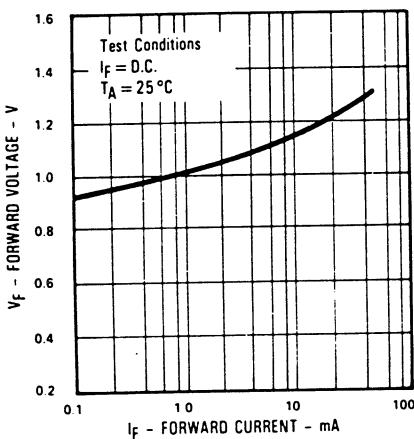
Electrical Characteristics ( $T_A = 25^\circ C$  unless otherwise noted)

SYMBOL	PARAMETER	MIN	TYP	MAX	UNITS	TEST CONDITIONS	
$E_e(APT)$	Apertured Radiant Incidence	OP165D OP165C OP165B OP165A	0.28 0.85 1.40 1.95		1.60 2.20	$mW/cm^2$	$I_F = 20 mA^{(3)}$ $I_F = 20 mA^{(3)}$ $I_F = 20 mA^{(3)}$ $I_F = 20 mA^{(3)}$ $I_F = 20 mA^{(3)}$
$V_F$	Forward Voltage			1.60	V	$I_F = 20 mA$	
$I_R$	Reverse Current			100	$\mu A$	$V_R = 2.0 V$	
$\lambda_p$	Wavelength at Peak Emission			935	nm	$I_F = 10 mA$	
B	Spectral Bandwidth Between Half Power Points			50	nm	$I_F = 10 mA$	
$\Delta\lambda_p/\Delta T$	Spectral Shift with Temperature			+0.30	$nm/^{\circ}C$	$I_F = \text{Constant}$	
$\theta_{HP}$	Emission Angle at Half Power Points			18	Deg.	$I_F = 20 mA$	
$t_r$	Output Rise Time			1000	ns	$I_F(PK) = 100 mA$ , $PW = 10 \mu s$ , D.C. = 10%	
$t_f$	Output Fall Time			500	ns		

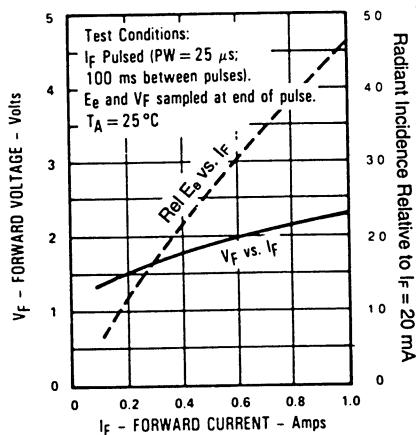
INFRARED  
EMITTING  
DIODES

## Typical Performance Curves

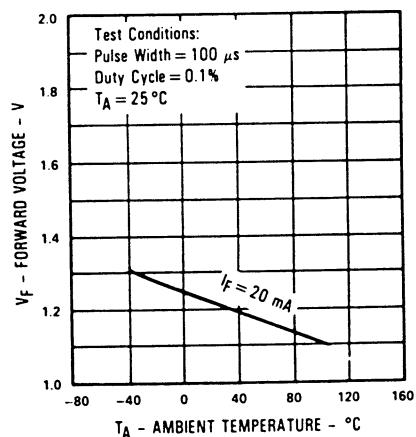
Forward Voltage vs  
Forward Current



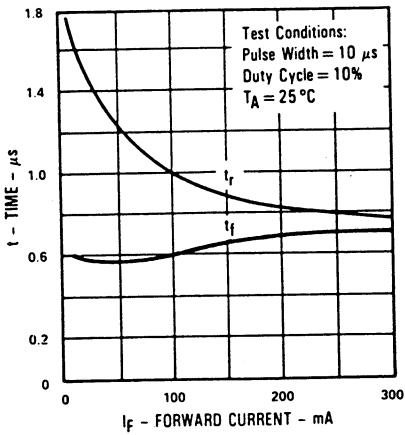
Forward Voltage and Relative Radiant  
Incidence vs. Forward Current



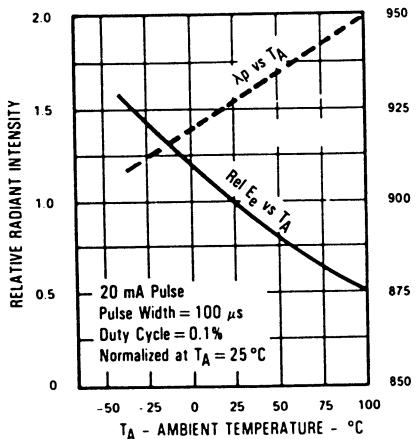
Forward Voltage vs  
Ambient Temperature



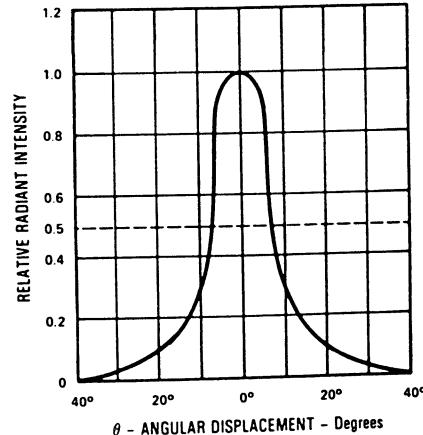
Rise Time and Fall Time vs  
Forward Current



Relative Radiant Intensity and Wavelength  
at Peak Emission vs Ambient Temperature



Relative Radiant Intensity vs  
Angular Displacement



Optek reserves the right to make changes at any time in order to improve design and to supply the best product possible.

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